

<b>Notice of References Cited</b>	Application/Control No. 10/696,125		Applicant(s)/Patent Under Reexamination HAWTOF ET AL.	
	Examiner G. Nagesh Rao		Art Unit 1722	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,306,322	04-1994	Ishikawa et al.	65/397
*	B	US-2002/0066402	06-2002	Price, Michael W.	117/81
*	C	US-5,106,401	04-1992	Ishikawa et al.	65/398
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2005062295 A	03-2005	Japan	WAKAYA et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Claims 1-20 from co-pending application 10/696,453 by Hawtof et. al.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.